RF Inductor



BWCM Series



Overview

Wire-wound RF inductors are electronic components designed to store energy in a magnetic field when electrical current passes through them. They are constructed by winding a conductive wire (usually copper or gold-plated) around a core material such as air, ceramic, or ferrite.

This configuration allows them to provide high inductance values with minimal power loss, especially at high frequencies.

Benefits

- 1. High Q-Factor (Quality Factor)
- 2. Ceramic body and wire wound construction provide high SRFs
- 3. Low DC resistance design
- 4. High Current Handling
- 5. Can maintain excellent thermal stability at different temperatures

Applications

- 1. Industrial and Medical Equipmen: RFID systems and medical imaging equipment.
- 2. Data Centers
- 3. Networking
- 4. Base Station
- 5. Consumer Electronics
- 6. Security system

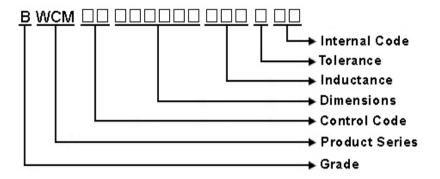
Product Information

Series	Size Code (JIS/EIA)	Inductance (nH)
BWCM	0603/0201	1 ~ 470
	1005/0402	
	1608/0603	





- 1 Scope: This specification applies to Wire Wound Ceramic Chip Inductors
- 2 Part Numbering:



3 Rating:

Operating Temperature: -40° C $\sim 125^{\circ}$ C

(Including self - temperature rise)

Storage Temperature: -40° C $\sim 125^{\circ}$ C

(The storage temperature range is for after the assembly)

4 Marking:

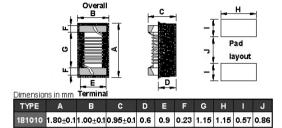
No Marking

5 Standard Testing Condition

	In case of doubt	
Temperature	Ordinary Temperature(15 to 35℃)	20 to 30℃
Humidity	Ordinary Humidity(25 to 85% RH)	50 to 80 %RH



6 Configuration and Dimensions and Unit Weight:



Net Weight (grms)	
SIZE CODE	Net Weight (grms)
181010	0.00449 (typ.)

7 Electrical Characteristics:

Part No.	Inductance (nH)	L/Q Test Freq. (MHz)	Q Min.	SRF (MHz)Min.	RDC (Ω)Max.	Irms (mA)Typ.	Tolerance
BWCM001810102N2□L8	2.2	100/250	24	15000	0.018	3200	C
BWCM001810102N4□L8	2.4	100/250	18	15000	0.026	2400	С
BWCM001810103N9□L8	3.9	100/250	30	10000	0.028	2200	G,C,B
BWCM001810104N3□L8	4.3	100/250	35	11600	0.036	2100	G,C,B
BWCM001810104N7□L8	4.7	100/250	25	10400	0.054	1500	G,C,B
BWCM001810104N8□L8	4.8	100/250	23	7300	0.081	1200	G,C,B,J
BWCM001810104N9□L8	4.9	100/250	23	7300	0.081	1200	G,C,B
BWCM001810105N6□L8	5.6	100/250	38	6650	0.04	1900	G,C
BWCM001810106N8□L8	6.8	100/250	40	6650	0.04	1900	G,C
BWCM001810107N5□L8	7.5	100/250	35	7000	0.048	1500	G,C
BWCM001810108N2□L8	8.2	100/250	38	4750	0.052	1600	G,C
BWCM001810108N7□L8	8.7	100/250	38	4750	0.052	1600	G,C
BWCM001810109N1□L8	9.1	100/250	38	4750	0.052	1600	G,C
BWCM001810109N5□L8	9.5	100/250	38	4750	0.052	1600	G,C
BWCM0018101010N□L8	10	100/250	38	4750	0.052	1600	J,G
BWCM0018101011N□L8	11	100/250	40	4750	0.052	1600	J,G
BWCM0018101012N□L8	12	100/250	37	5000	0.064	1500	J,G
BWCM0018101013N□L8	13	100/250	37	5000	0.064	1500	J,G
BWCM0018101015N□L8	15	100/250	38	4600	0.075	1400	J,G
BWCM0018101016N□L8	16	100/250	40	4600	0.075	1400	J,G
BWCM0018101018N□L8	18	100/250	40	4600	0.075	1400	J,G
BWCM0018101019N□L8	19	100/250	40	4600	0.075	1400	J,G
BWCM0018101022N□L8	22	100/250	40	3450	0.086	1300	J,G
BWCM0018101023N□L8	23	100/250	40	3450	0.086	1300	J,G
BWCM0018101024N□L8	24	100/250	40	3450	0.086	1300	J,G

NOTE: □-tolerance B=±0.1nH / C=±0.2nH / J=±5% / G=±2%

5.Offset value : -0.771nH

^{1.} Operating temperature range - 4 0 $^{\circ}$ C ~ 1 2 5 $^{\circ}$ C(Including self - temperature rise)

^{2.}Irms for a 15°C temperature rise from 25°C ambient.

^{3.}L/Q Test OSC @200mV.

^{4.}Inductance would be correct Chilisin standard piece.



Part No.	Inductance (nH)	L/Q Test Freq. (MHz)	Q Min.	SRF (MHz)Min.	RDC (Ω)Max.	Irms (mA)Typ.	Tolerance
BWCM0018101027N□L8	27	100/250	40	3600	0.098	1200	J,G
BWCM0018101028N□L8	28	100/250	40	3600	0.098	1200	J,G
BWCM0018101030N□L8	30	100/250	40	2880	0.12	1100	J,G
BWCM0018101033N□L8	33	100/250	40	3150	0.11	1100	J,G
BWCM0018101036N□L8	36	100/250	37	3000	0.2	910	J,G
BWCM0018101039N□L8	39	100/250	40	3280	0.16	1000	J,G
BWCM0018101043N□L8	43	100/250	40	2780	0.21	840	J,G
BWCM0018101047N□L8	47	100/200	32	2700	0.23	830	J,G
BWCM0018101051N□L8	51	100/200	32	2700	0.23	830	J,G
BWCM0018101056N□L8	56	100/200	38	2600	0.26	770	J,G
BWCM0018101068N□L8	68	100/200	37	2380	0.38	630	J,G
BWCM0018101072N□L8	72	100/150	34	2330	0.47	560	J,G
BWCM0018101075N□L8	75	100/150	28	2280	0.41	590	J,G
BWCM0018101082N□L8	82	100/150	34	2230	0.5	550	J,G
BWCM0018101091N□L8	91	100/150	33	1900	0.54	520	J,G

NOTE: □-tolerance B=±0.1nH / C=±0.2nH / J=±5% / G=±2%

5.Offset value: -0.771nH

^{1.} Operating temperature range $-40\,^{\circ}\text{C} \sim 125\,^{\circ}\text{C}$ (Including self - temperature rise)

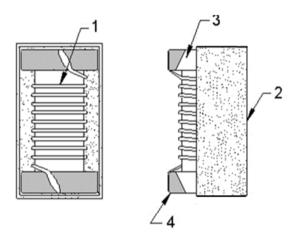
^{2.}Irms for a 15°C temperature rise from 25°C ambient.

^{3.}L/Q Test OSC @200mV.

^{4.}Inductance would be correct Chilisin standard piece.



BWCM00181010 Series 8.1 Construction:



8.2 Material List:

NO	PART	MATERIAL
1	WIRE	Grade 180
2	EPOXY	UV GLUE
3	CORE	CERAMIC
4	TERMINAL	Ag/Ni/Sn



9 Reliability Of Ceramic Wire Wound Chip Inductor/CERAMIC SERIES

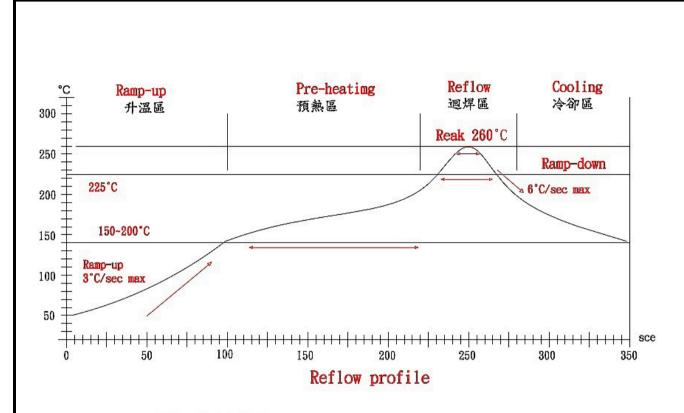
775			~	
1_1 ⊨	nviranm	IONTALI	Performa	nca

No	ltem	Specification		Test Method		
1-1-1	Temperature Cycle	Appearance: No Damage	One cycle:			
		Inductance:within±10% of	Step	Temperature (°ℂ)	Time (min)	
		initial value	1	-40±3	30	
		Q change:within±30% of	2	25±2	15	
		initial value	3	125±3	30	
			4	25±2	15	
			Total: 5 cycle	es		
			Measured Af	fter Exposure in The Room Condit	tion For 1hrs	
1-1-2	High Temperature Resistance		Temperature	e: 125±3℃		
			Time: 1000H	Irs		
			Measured After Exposure In The Room Condition For 1Hrs			
1-1-3	Low Temperature Resistance		Temperature	e: -40±3°C		
			Time: 1000H	Irs		
			Measured Af	fter Exposure In The Room Condi	tion For 1Hrs	
1-1-4	Humidity Load Life	There should be no evidence	Temperature: 40±2℃			
		of short or open circle	Relative Humidity: 90~95%			
			Load: Allowed DC Current			
			Time: 96Hrs			

1-2.Mechanical Performance

No	Item	Specification	Test Method
1-2-1	Vibration Test	1.Appearance: No Damage	Test device shall be soldered on the substrate.
	(Low Frequency)	2.Inductance:within±10% of	2. Oscillation frequency: 10 to 55 to 10Hz for 1min.
		initial value	3. Amplitude: 1.5mm
		3.Q change:within±30% of	4. Time: 2hrs for each axis(X, Y & Z),total 6hrs
		initial value	
1-2-2	Resistance TO	Appearance: No Damage	The device should be reflow soldered on PCB
	Soldering Heat		(peak 260°C±5°C for 10 seconds)
			2. Solder Composition: Sn/Ag3.0/Cu0.5
			3. Test time: 6 minutes
1-2-3	Solder ability	The electrodes shall be	1. Pre-Heating: 150℃,1min.
		at least 95% covered	2. Solder Composition: Sn/Ag3.0/Cu0.5
		with new solder coating	3. Solder Temperature: 245±5°ℂ.
			4. Immersion Time: 4±1 sec.
1-2-4	Component	1 Lbs. For 0402	The device should be reflow soldered (245±5° For
	Adhesion	2 Lbs. For 0603	10 seconds) to a tinned copper substrate. A force gauge
	(Push Test)	4 Lbs. For The Rest	should be applied to the side of the component.
			The device must withstand a minimum force of 2 or 4 pounds
			without a failure of the termination attached to component





Lead-Free(LF)標準溫度分析範圍

Refer to J-STD-020C

管制項目 Item.	升溫區 Ramp-up	預熱區 Pre-heating	迴焊區 Reflow	Peak Temp	冷卻區 Cooling
溫度範圍 Temp.scope	R.T ~ 150°C	150°C ~ 200°C	Above 217°C	260±5°C	Peak Temp.~150℃
標準時間 Time spec.	-	60 ~ 180 sec	60 ~ 150 sec	20 ~ 40 sec	-
實際時間 Time result	12	75 ~ 100 sec	90 ~ 120 sec	20 ~ 35 sec	-

NOTE:

- 1.Re-flow possible times: within 3 times
- 2. Nitrogen adopted is recommendes while in re-flow
- 3. Products can only be soldered with reflow



10 Packaging:

10.1 Packaging -Cover Tape

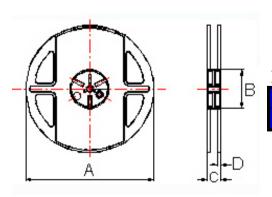
The force for tearing off cover tape is 10 to 100 grams in the arrow direction.



10.2 Packaging Quantity

TYPE	PCS/REEL
181010	4000

10.3 Reel Dimensions



Dimensions in mm

TYPE	Α	В	С	D
181010	178	60	12	1.5

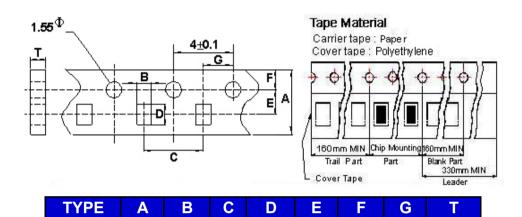


1.20

8.0

10 Packaging:

10.4 Tape Dimensions in mm



2

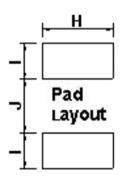
3.5

1.75

1.1

11 Recommended Land Pattern:

181010



Dimensions in mm

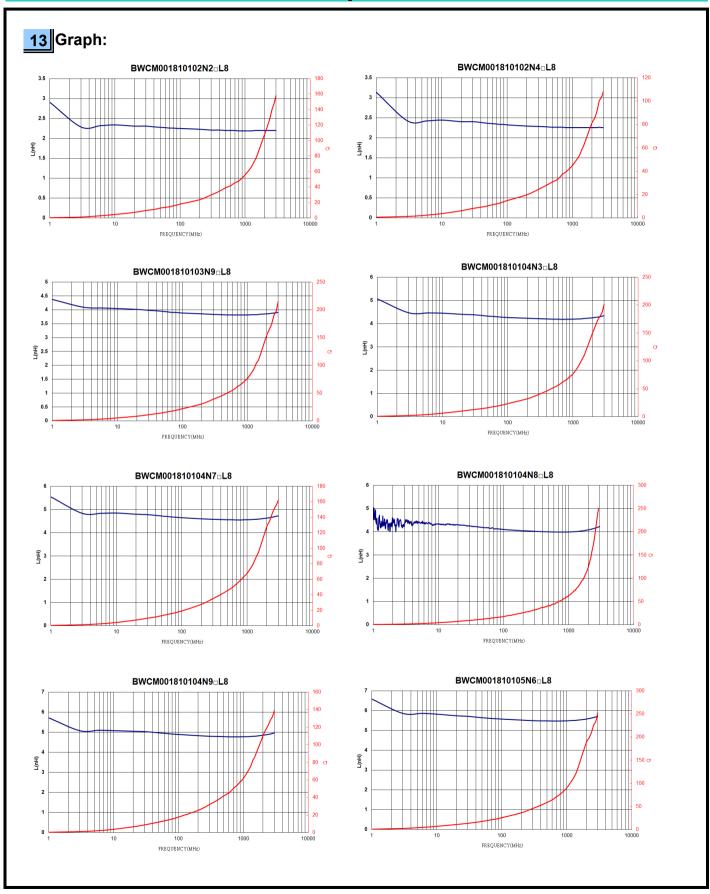
4

TYPE	H(In/mm)	l(ln/mm)	J(In/mm)
181010	0.045/1.15	0.022/0.57	0.034/0.86

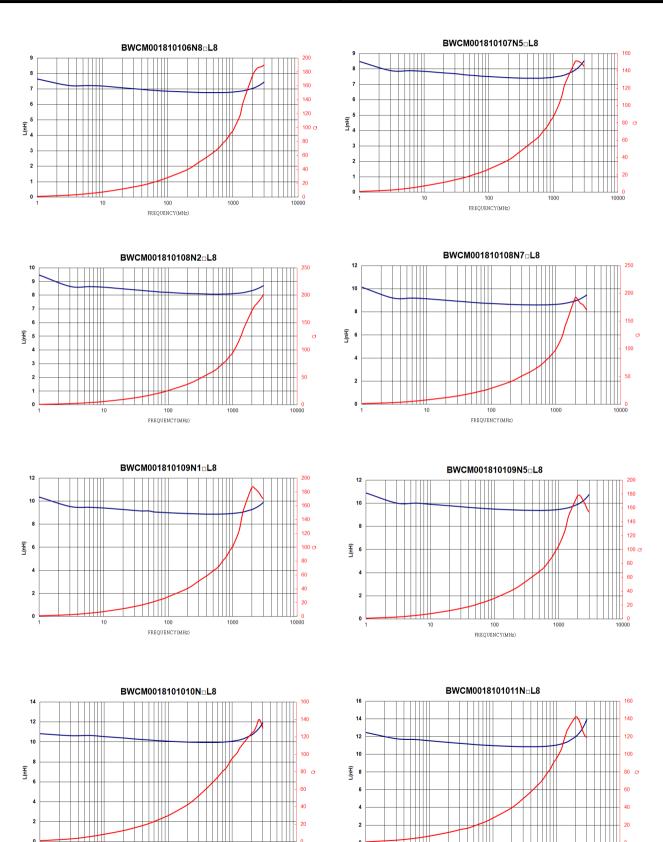
12 Note:

- 1. Please make sure that your product has been evaluated and confirmed against your specifications when our product is mounted to your product.
- 2. Do not knock nor drop.
- 3. All the items and parameters in this product specification have been prescribed on the premise that our product is used for the purpose,under the condition and in the environment agreed upon between you and us. You are requested not to use our product deviating from such agreement.
- 4. The storage period is less than 12 months. Be sure to follow the storage conditions (Temperature: 5 to 40°C, Humidity: 10 to 75% RHor less).
- If the storage period elapses, the soldering of the terminal electrodes may deteriorate.
- 5.Do not use or store in locations where there are conditions such as gas corrosion (salt, acid, alkali, etc.).
- 6. The moisture sensitivity level (MSL) of products is classified as level 1.









FREQUENCY(MHz)



